# Journal of International Technology and Information Management

Volume 31 | Issue 1

Article 6

2022

## JITIM Front Cover Vol 31 1 2022

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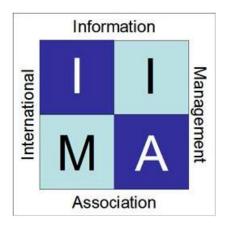
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#### **Recommended Citation**

(2022) "JITIM Front Cover Vol 31 1 2022," *Journal of International Technology and Information Management*: Vol. 31: Iss. 1, Article 6.
DOI: https://doi.org/10.58729/1941-6679.1548
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